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Mori, K.; Miyamoto, T.; Yokouchi, N.; Inaba, Y.; Koyama, F.; Iga, K.;
Indium Phosphide and Related Materials, 1994. Conference Proceedings., Sixth International Conference on , 27-31 Mar 1994
Page(s): 311 -314

[\[Abstract\]](#) [\[PDF Full-Text \(244 KB\)\]](#) **IEEE CNF****2 Modified multiquantum barrier for 600 nm range AlGaInP lasers**

Takagi, T.; Koyama, F.; Iga, K.;
Electronics Letters , Volume: 27 Issue: 12 , 6 Jun 1991
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